32,768 WORD x 8 Bit CMOS Static RAM

FEATURES

- **Fast Access Time: 70, 85, 100, 120ns (Max.)**
- **Low Power Dissipation**
  - **Standby (CMOS): 10μW (Typ.) L-Version**
  - **5μW (Typ.) LL-Version**
  - **Operating : 35mW (Typ.)**
- **Single 5V ± 10% Power Supply**
- **TTL Compatible Inputs and Outputs**
- **Fully Static Operation**
  - **No clock or refresh required**
- **Three State Outputs**
- **Low Data Retention Voltage: 2V (Min.)**
- **Standard Pin Configuration**
  - **KM62256BLP/BLP-L: 28-pin DIP**
  - **KM62256BLG/BLG-L: 28-pin SOP**
  - **KM62256BLS/BLS-L: 28-Pin SDIP**
  - **KM62256BLT/BLT-L: 32-pin TSOP, Standard**
  - **KM62256BLR/BLR-L: 32-pin TSOP, Reverse**
  - **KM62256BLTG/BLTG-L: 28-pin TSOP, Standard**
  - **KM62256BLRG/BLRG-L: 28-pin TSOP, Reverse**

GENERAL DESCRIPTION

The KM62256BL/BL-L is a 262,144-bit high-speed Static Random Access Memory organized as 32,768 words by 8 bits.

The device is fabricated using Samsung's advanced CMOS process with polyresistors.

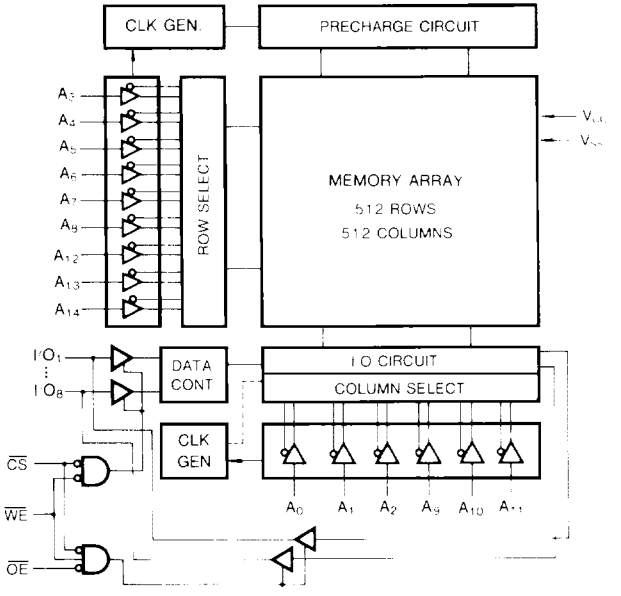
The KM62256BL/BL-L has an output enable input for precise control of the data outputs.

It also has a chip enable input for the minimum current power down mode.

The KM62256BL/BL-L has been designed for high speed and low power application. It is particularly well suited for battery back-up nonvolatile memory application.

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FUNCTIONAL BLOCK DIAGRAM

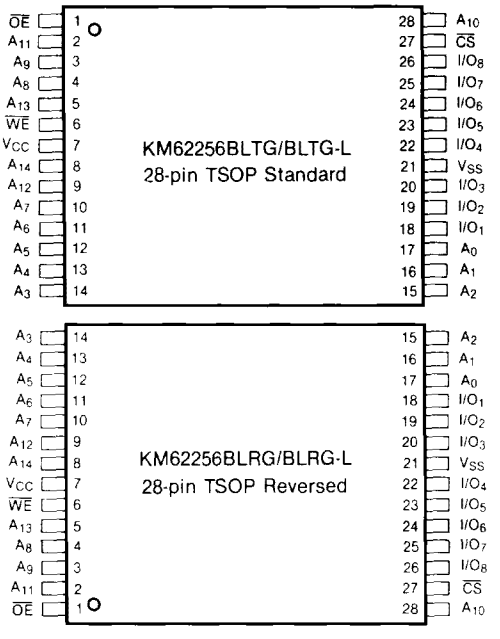


PIN CONFIGURATIONS

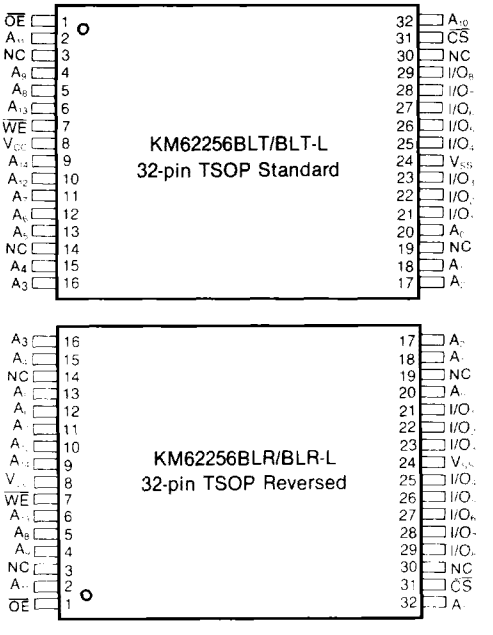
Pin Name	Pin Function
A_0-A_{14}	Address Inputs
$\overline{WE}$	Write Enable Input
$\overline{CS}$	Chip Select Input
$\overline{OE}$	Output Enable Input
I/O_1-I/O_8	Data Inputs/Outputs
V_{CC}	Power (+5V)
V_{SS}	Ground
N.C.	No Connection (32-TSOP only)

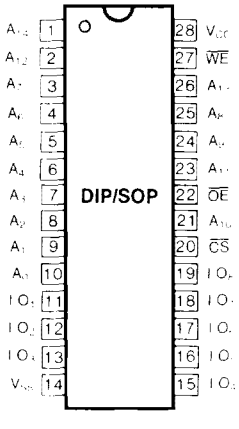
PIN CONFIGURATIONS (Top View)

28-pin TSOP (0813.4)



32-pin TSOP (0814)





ABSOLUTE MAXIMUM RATINGS*

Item	Symbol	Rating	Unit
Voltage on Any Pin Relative to V_{SS}	V_{IN}, V_{OUT}	−0.5 to V_{CC} + 0.5	V
Voltage on V_{CC} Supply Relative to V_{SS}	V_{CC}	−0.5 to 7.0	V
Power Dissipation	P_D	1.0	W
Storage Temperature	T_{STG}	−65 to 150	°C
Operating Temperature	T_A	0 to 70	°C
Soldering Temperature and Time	T_{solder}	260°C, 10 sec (Lead only)	—

* Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress ratlng only and functional operation of the device at these or any other conditions above those indicated in the operating section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

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RECOMMENDED OPERATING CONDITIONS (T_A = 0 to 70°C)

Item	Symbol	Min	Typ	Max	Unit
Supply Voltage	V_{CC}	4.5	5.0	5.5	V
Ground	V_{SS}	0	0	0	V
Input High Voltage	V_{IH}	2.2	—	V_{CC} + 0.5	V
Input Low Voltage	V_{IL}	−0.5*	—	0.8	V

* V_{IL}(min) = −3.0V for ≤50ns Pulse

DC AND OPERATING CHARACTERISTICS

(T_A = 0 to 70°C, V_{CC} = 5V ± 10%, unless otherwise specified)

Item	Symbol	Test Conditions		Min	Typ*	Max	Unit
Input Leakage Current	I_{LI}	$V_{IN} = V_{SS}$ to V_{CC}		−1	—	1	μA
Output Leakage Current	I_{LO}	$\overline{CS} = V_{IH}$ or $\overline{OE} = V_{IH}$ or $\overline{WE} = V_{IL}$, $V_{I/O} = V_{SS}$ to V_{CC}		−1	—	1	μA
Operation Power Supply Current	I_{CC}	$\overline{CS} = V_{IL}$, $V_{IN} = V_{IH}$ or V_{IL}, $I_{I/O}$ = 0mA		—	7	15	mA
Average Operating Current	I_{CC1}	Cycle Time = 1μs, 100% Duty, $\overline{CS} \leq 0.2V$, $V_{IL} \leq 0.2V$, $V_{IH} \geq V_{CC} - 0.2V$, $I_{I/O}$ = 0mA		—	—	7	mA
	I_{CC2}	Min Cycle, 100% Duty, $\overline{CS} = V_{IL}$, $I_{I/O}$ = 0mA		—	45	70	mA
Standby Power Supply Current	I_{SB}	$\overline{CS} = V_{IH}$		—	—	1	mA
	I_{SB1}	$\overline{CS} \geq V_{CC} - 0.2V$, $V_{IN} \geq V_{CC} - 0.2V$ or $V_{IN} \leq 0.2V$	L-Ver.	—	2	100	μA
			LL-Ver.	—	1	20	μA
Output Low Voltage	V_{OL}	I_{OL} = 2.1mA		—	—	0.4	V
Output High Voltage	V_{OH}	I_{OH} = −1.0mA		2.4	—	—	V

* Typ: V_{CC} = 5V, T_A = 25°C

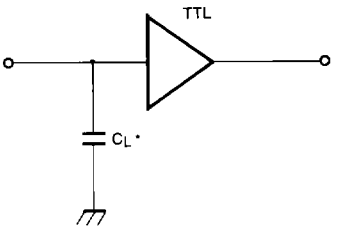
CAPACITANCE ($f = 1MHz$, $T_A = 25°C$)

Item	Symbol	Test Conditions	Min	Max	Unit
Input Capacitance	C_{IN}	$V_{IN} = 0V$	—	6	pF
Input/Output Capacitance	$C_{I/O}$	$V_{I/O} = 0V$	—	8	pF

Note: Capacitance is sampled and not 100% tested.

TEST CONDITIONS ($T_A = 0$ to $70°C$, $V_{CC} = 5V \pm 10\%$, unless otherwise specified)

Parameter	Value
Input Pulse Level	0.8 to 2.4V
Input Rise and Fall Times	5ns
Input and Output Timing Reference Levels	1.5V
Output Loads	$C_L = 100pF + 1$ TTL



* Including Scope and Jig Capacitance

READ CYCLE

Parameter	Symbol	KM62256BL-7 KM62256BL-7L		KM62256BL-8 KM62256BL-8L		KM62256BL-10 KM62256BL-10L		KM62256BL-12 KM62256BL-12L		Unit
		Min	Max	Min	Max	Min	Max	Min	Max	
Read Cycle Time	t_{RC}	70		85		100		120		ns
Address Access Time	t_{AA}		70		85		100		120	ns
Chip Select to Output	t_{CO}		70		85		100		120	ns
Output Enable to Valid Output	t_{OE}		35		45		50		60	ns
Chip Select to Low-Z Output	t_{LZ}	10		10		10		10		ns
Output Enable to Low-Z Output	t_{OLZ}	5		5		5		5		ns
Chip Disselect to High-Z Output	t_{HZ}	0	30	0	30	0	35	0	40	ns
Output Disable to High-Z Output	t_{OHZ}	0	30	0	30	0	35	0	40	ns
Output Hold from Address Change	t_{OH}	5		5		10		10		ns

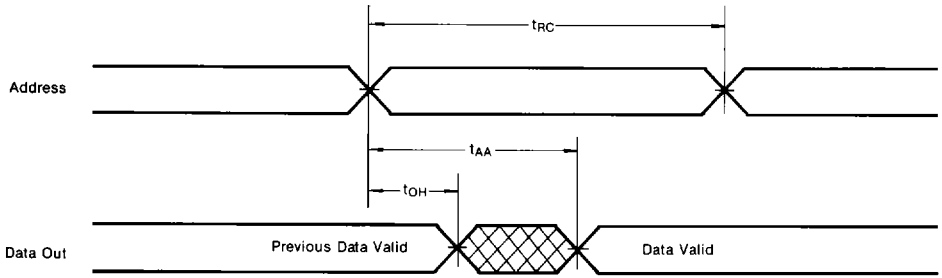
WRITE CYCLE

Parameter	Symbol	KM62256BL-7 KM62256BL-7L		KM62256BL-8 KM62256BL-8L		KM62256BL-10 KM62256BL-10L		KM62256BL-12 KM62256BL-12L		Unit
		Min	Max	Min	Max	Min	Max	Min	Max	
Write Cycle Time	t_{WC}	70		85		100		120		ns
Chip Select to End of Write	t_{CW}	60		75		80		85		ns
Address Valid to End of Write	t_{AW}	60		75		80		85		ns
Address Set-up Time	t_{AS}	0		0		0		0		ns
Write Pulse Width	t_{WP}	50		60		60		70		ns
Write Recovery Time	t_{WR}	0		0		0		0		ns
Write to Output High-Z	t_{WHZ}	0	25	0	30	0	30	0	40	ns
Data to Write Time Overlap	t_{DW}	30		40		40		50		ns
Data Hold from Write Time	t_{DH}	0		0		0		0		ns
End Write to Output Low-Z	t_{OW}	5		5		5		5		ns

TIMING DIAGRAMS

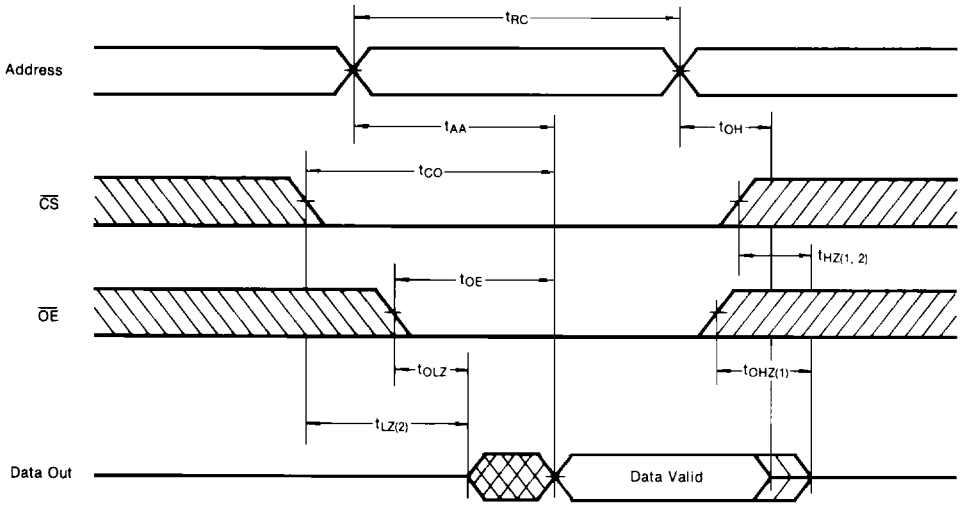
TIMING WAVEFORM OF READ CYCLE (1) (Address Controlled)

($\overline{CS}$ = $\overline{OE}$ = V_{IL}, $\overline{WE}$ = V_{IH})



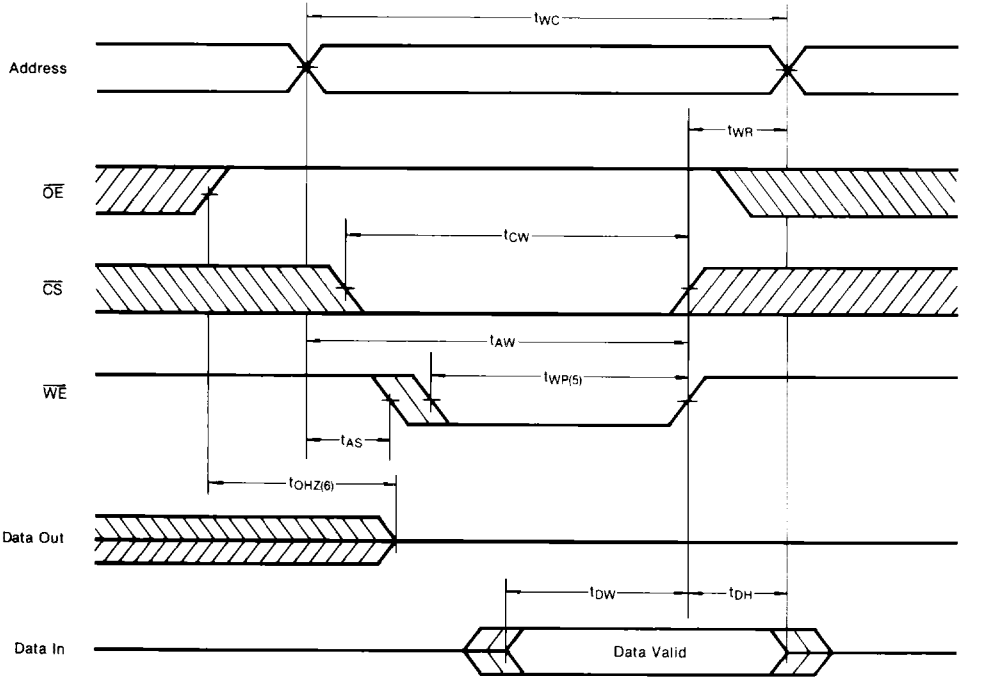
TIMING WAVEFORM OF READ CYCLE (2)

($\overline{WE}$ = V_{IH}) (Note 1, 2, 3, 4)



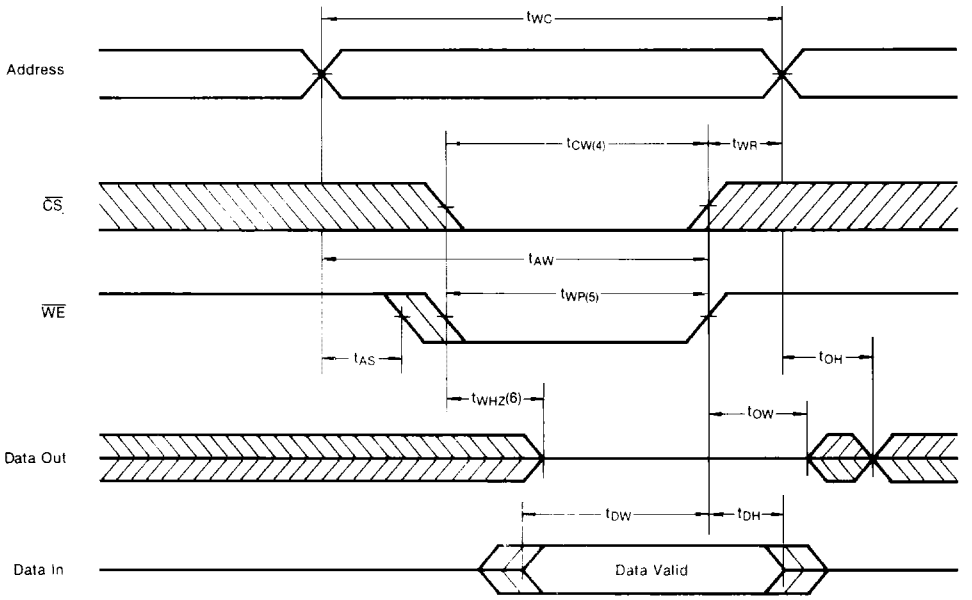
TIMING WAVEFORM OF WRITE CYCLE (3)

($\overline{OE}$ Clocked) (Note 5, 6, 7, 8)



TIMING WAVEFORM OF WRITE CYCLE (4)

($\overline{OE}$ Low Fixed) (Note 5, 6, 7, 8, 9)



Notes

1. t_{HZ} and t_{OHZ} are defined as the time at which the outputs achieve the open circuit condition and are not referenced to the V_{OH} or V_{OL} level.
2. At any given temperature and voltage condition t_{HZ} (max.) is less than t_{LZ} (min.) both for a given device and from device to device.
3. $\overline{WE}$ is high for read cycle.
4. Address valid prior to or coincident with $\overline{CS}$ transition Low.
5. A write occurs during the overlap (t_{WP}) of a low $\overline{CS}$ and $\overline{WE}$.
6. During this period, I/O pins are in the output state. The input signals out of phase must not applied.
7. $\overline{CS}$ or $\overline{WE}$ must be high during address transition state.
8. If $\overline{OE}$ is high, I/O pins remain in a high-impedance state.
9. $\overline{OE}$ is continuously low ($\overline{OE} = V_{IL}$).

FUNCTIONAL DESCRIPTION

$\overline{CS}$	$\overline{WE}$	$\overline{OE}$	Mode	I/O Pin	V_{CC} Current
H	X*	X	Power Down	High-Z	I_{SB}, I_{SB1}
L	H	H	Output Disable	High-Z	I_{CC}
L	H	L	Read	D_{OUT}	I_{CC}
L	L	X	Write	D_{IN}	I_{CC}

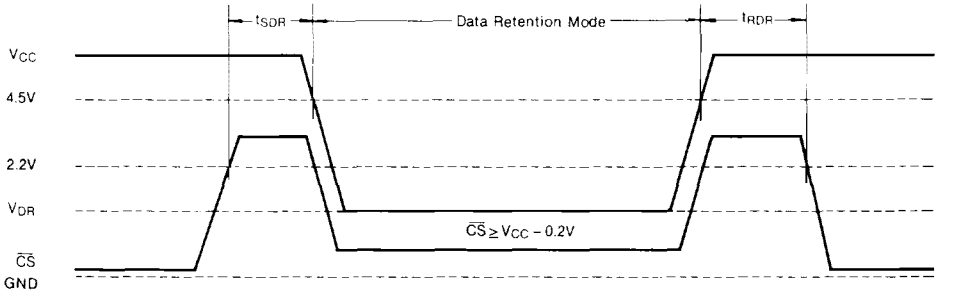
* X means Don't Care.

DATA RETENTION CHARACTERISTICS (T_A = 0 to 70°C)

Parameter	Symbol	Test Condition		Min	Typ	Max	Unit
V_{CC} for Data Retention	V_{DR}	$\overline{CS} \geq V_{CC} - 0.2V$		2.0		5.5	V
Data Retention Current	I_{DR}	V_{CC} = 3.0V $\overline{CS} \geq V_{CC} - 0.2V$	L		1	50*	μA
			L-L		0.5	10**	μA
Data Retention Set-up Time	t_{SDR}	See Data Retention Waveforms (below)		0			ns
Recovery Time	t_{RDR}			t_{RC}***			ns

* 20μA (Max.) at 0°C ~ 40°C
** 3μA (Max.) at 0°C ~ 40°C
*** t_{RC}: Read Cycle Time

DATA RETENTION WAVEFORM ($\overline{CS}$ Controlled)

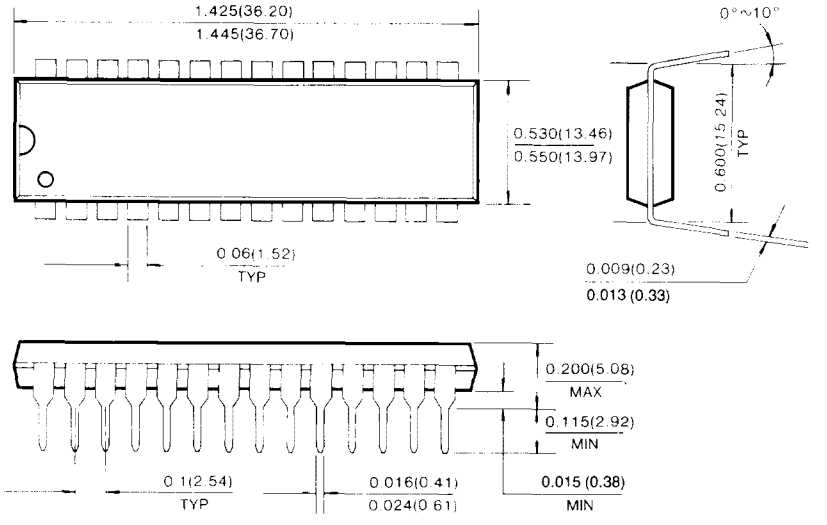


SAMSUNG ELECTRONICS

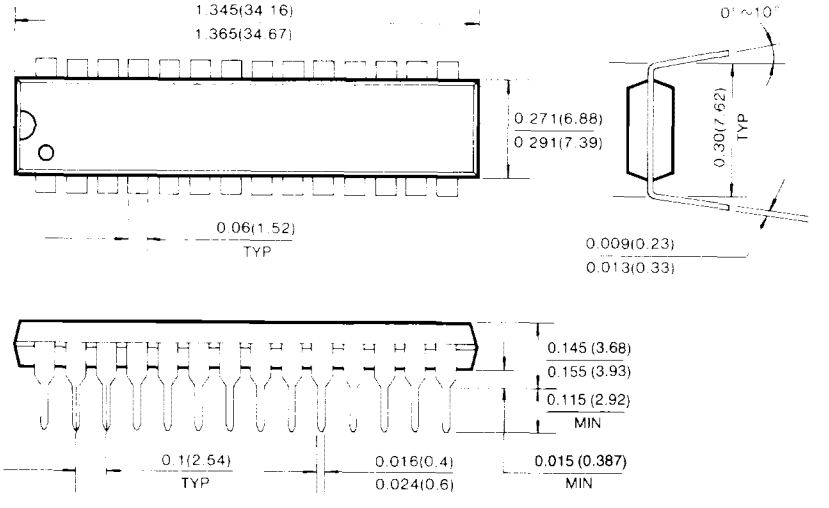
PACKAGE DIMENSIONS

28 PIN PLASTIC DUAL IN LINE PACKAGE (600 mil)

Unit: Inches (Millimeters)



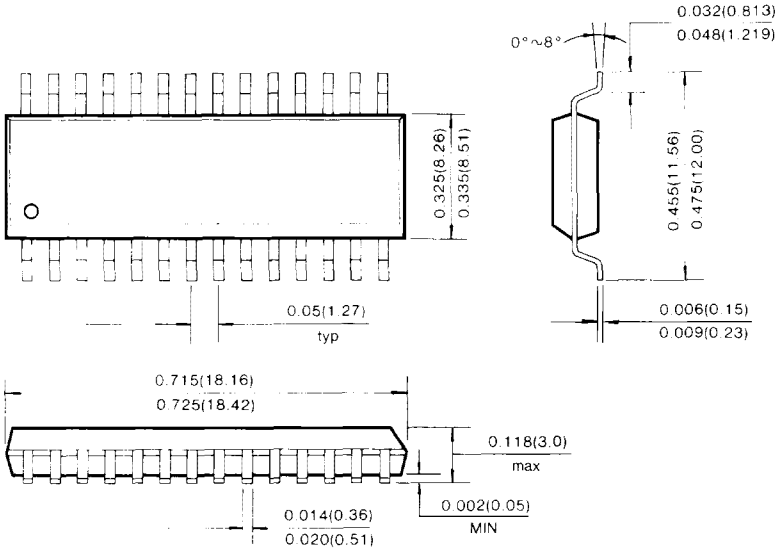
28 PIN PLASTIC DUAL IN LINE PACKAGE (300mil)



PACKAGE DIMENSIONS (Continued)

28 PIN PLASTIC SMALL OUT LINE PACKAGE (330 mil)

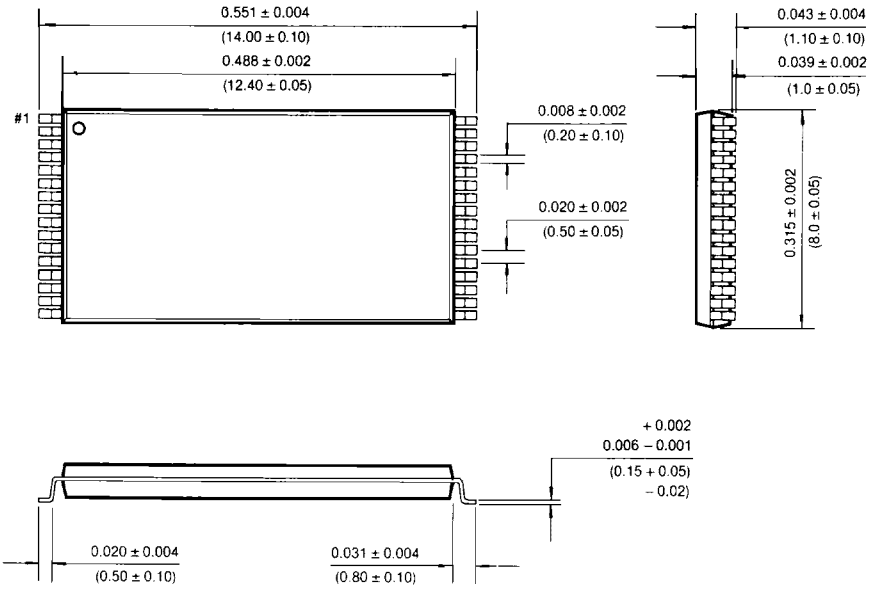
Units: Inches (millimeters)



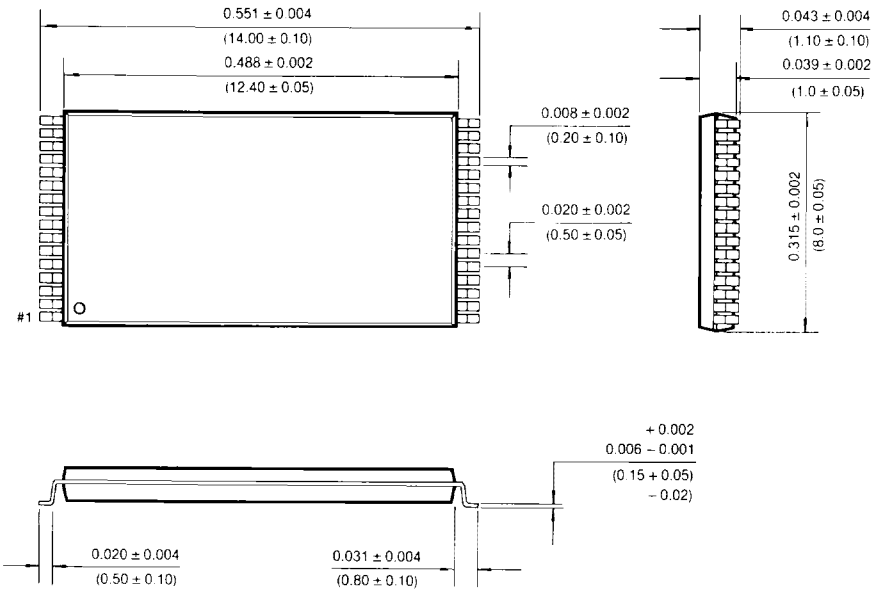
PACKAGE DIMENSIONS

32 PIN THIN SMALL OUTINE PACKAGE (0814F)

Unit: Inches (millimeters)

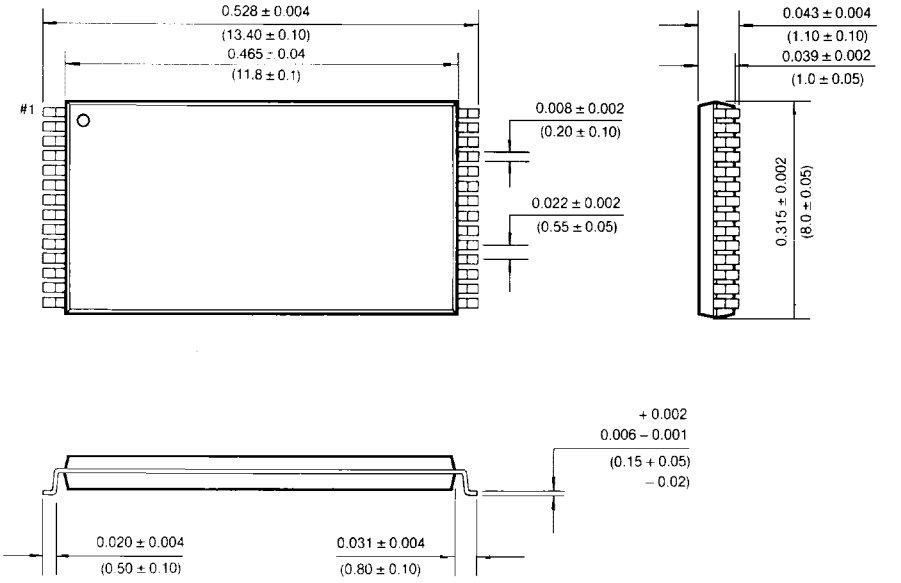


32 PIN THIN SMALL OUTLINE PACKAGE (0814R)



28 PIN THIN SMALL OUTLINE PACKAGE (0813.4F)

Unit: Inches (millimeters)



28 PIN THIN SMALL OUTLINE PACKAGE (0813.4R)

